Notice of References Cited Application/Control No. 10/644,014 Examiner Glenn Zimmerman Applicant(s)/Patent Under Reexamination BAE ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,882,108	04-2005	Kim et al.	313/582
-	В	US-6,198,222	03-2001	Chang, Shan-Han	313/582
	С	US-2002/0159240	10-2002	Watanabe et al.	361/752
	D	US-2004/0036396	02-2004	Kang et al.	313/231.31
	E	US-6,833,674	12-2004	Kaneko et al.	313/587
	F	US-2004/0027073	02-2004	Nomoto et al.	313/583
	G	US-6,288,489	09-2001	Isohata et al.	313/582
	Н	US-6,744,186	06-2004	Oishi et al.	313/46
	ı	US-6,633,126	10-2003	Tsai et al.	313/582
	J	US-2002/0153840	10-2002	Isohata et al.	313/582
	к	US-6,373,702	04-2002	Oishi et al.	361/704
	L	US-5,831,374	11-1998	Morita et al.	313/46
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11242442 A	09-1999	Japan	GOTO et al.	G09F 09/00
	0					
	Р					
	Q					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.